

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/488,969	BAER ET AL.	
Examiner	Art Unit	
Maikhanh Nauvon	2176	

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	Search	9/9/2005	МК		
Updated	Search	2/24/2006	MK		
Updated	Search	8/8/2006	MK		
Updated	Search	2/13/2007	мк		
Updated	Search	6/25/2007	мк		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor Name Search	9/9/2005	мк
West Updated Search (See Search History Printout)	9/9/2005	МК
West Updated (See Search History Printout)	2/24/2006	МК
West Updated (See Search History Printout)	8/8/2006	МК
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	2/13/2007	МК
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	6/25/2007	MK